

Notice of References Cited

Application/Control No.

10/567,355

Applicant(s)/Patent Under

Reexamination

MIYAZAKI ET AL.

Examiner

/Susan W. Berman/

Art Unit

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2006/0202220	09-2006	Hayashi, Naoki	257/098
*	B US-6,599,954	07-2003	Hayashi et al.	522/25
*	C US-7,087,702	08-2006	Ogura et al.	528/106
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

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N					
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